		Pre-PCN						Write		Review		Approval	
SEOUL								replaced by BPM					
Draft			SVC CS CT				/			/	/		
The cha	ange	Chip Bump Material Change											
Applied product		Refer to explanati			on sheet Cha l			nged cess	LED Chip Bump paste				
4M			Evironment (production site)			Method	nn)	leguinm	Machine		Material (New material)		
Reas	on	LED DUV	(production site) (classification) (equipment improvement) (New material) D DUV3030 Pakage's(CUD7QF1A , CU7GF1A(B)) chip bump and process change (Au → AuSn) for the rpose of quality improvement.										
Applied after cutomer's a			approval	BOM Change No			_	cted cess	LED Paka Attach)	age's Fror	nt process(Die		
	lte	em		AS-IS TO-BE									
■ Change Point - LED Chip Bump paste				■ As-Is - LED Pakage's Front process(Flip bonding) - Chip Bump : Au Bump Paste *CUD7QF1A, CUD7GF1A, CUD7GF1B				ng)	■ To-Be - LED Pakage's Front process(Die Attach) - Chip Bump: AuSn Paste CUD7QF1A, CUD7GF1A, CUD7GF1B				
				■ 변경 전 BOM 내역					■ 변경 후 BOM 내역				
				Application of Chip Paste Au				I	Application of Chip Paste AuSn				
■ Effect													
quality improvement													
Review													
■ Comment (draft team)													
■ Comment (approval team)													
Status		Applied Date			Initial product			Expected	Expected date of shipment.		unchanged stock		
		after customer's app						-				-	
Approval (internal)		Approval No (waiting)		No app	pproved -		-	PCN to a customer		No	need -	Need o	
,		, 9,		am	team						iew	approval	
Reception team				by BPM		Approval team		replaced by BPM					
~ _		/			/				/		/	/	

문서명 : 변경 관리 절차서 서식 Rev : 03